



SEMICONDUCTOR®

March 2009

FDP20N50 / FDPF20N50T

500V N-Channel MOSFET

Features

- 20A, 500V, $R_{DS(on)} = 0.23\Omega @V_{GS} = 10 V$
- Low gate charge (typical 45.6 nC)
- Low C_{rss} (typical 27 pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability



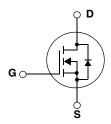
Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.







Absolute Maximum Ratings

Symbol	Parameter		FDP20N50	FDP20N50 FDPF20N50T		
V _{DSS}	Drain-Source Voltage		500		V	
I _D	Drain Current	- Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		20 12.9	20 * 12.9 *	A A
I _{DM}	Drain Current	- Pulsed	(Note 1)	80	80 *	Α
V_{GSS}	Gate-Source voltage		±30		V	
E _{AS}	Single Pulsed Avalanche Energy (Note:		(Note 2)	1110		mJ
I _{AR}	Avalanche Current		(Note 1)	20		Α
E _{AR}	Repetitive Avalanche Energy (Note		(Note 1)	25		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5		V/ns	
P _D	Power Dissipation	(T _C = 25°C) - Derate above 25°C		250 2.0	38.5 0.3	W W/°C
T _{J,} T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C	
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300		°C	

^{*} Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FDP20N50	FDPF20N50T	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.5	3.3	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	°C/W



查询"FDPF20N50T"供应商 Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP20N50	FDP20N50	TO-220	-	-	50
FDPF20N50T	FDPF20N50T	TO-220F	-	-	50

Electrical Characteristics $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Conditions	Min.	Тур.	Max	Units
Off Charac	teristics	1		ı		
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	500			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C		0.5		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 500V, V _{GS} = 0V V _{DS} = 400V, T _C = 125°C			1 10	μA μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30V, V _{DS} = 0V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30V, V _{DS} = 0V			-100	nA
On Charac	teristics	•		•		•
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 10A		0.20	0.23	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 40V, I_D = 10A$ (Note 4)		24.6		S
Dynamic C	Characteristics	•				
C _{iss}	Input Capacitance	$V_{DS} = 25V$, $V_{GS} = 0V$,		2400	3120	pF
C _{oss}	Output Capacitance	f = 1.0MHz		355	465	pF
C _{rss}	Reverse Transfer Capacitance			27		pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 250V, I_{D} = 20A$		95	200	ns
t _r	Turn-On Rise Time	$R_G = 25\Omega$		375	760	ns
t _{d(off)}	Turn-Off Delay Time			100	210	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		105	220	ns
Qg	Total Gate Charge	V _{DS} = 400V, I _D = 20A		45.6	59.5	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10V		14.8		nC
Q_{gd}	Gate-Drain Charge	(Note 4, 5)		21.6		nC
Drain-Sour	rce Diode Characteristics and Maximun	n Ratings		ı		
I _S	Maximum Continuous Drain-Source Diode Forward Current				20	А
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				80	Α
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0V, I _S = 20A			1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _S = 20A		507		ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s $ (Note 4)		7.20		μС

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 5.0mH, I $_{AS}$ = 20A, V $_{DD}$ = 50V, R $_{G}$ = 25 $\!\Omega$, Starting T $_{J}$ = 25 $^{\circ}C$
- 3. $I_{SD} \le 20 A$, $di/dt \le 200 A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse width $\leq 300 \mu s, \, \text{Duty Cycle} \leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics



Typical Performance Characteristics

Figure 1. On-Region Characteristics

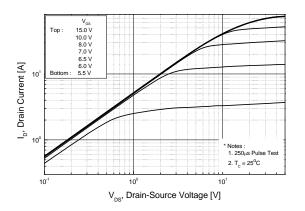


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

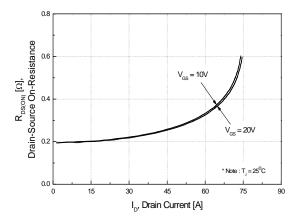


Figure 5. Capacitance Characteristics

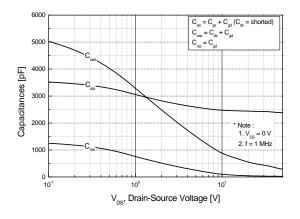


Figure 2. Transfer Characteristics

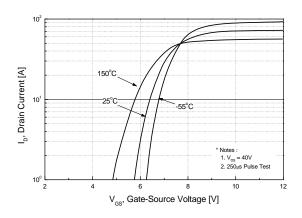


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

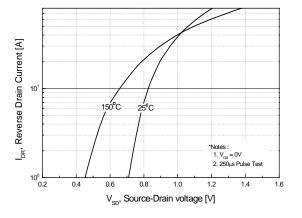
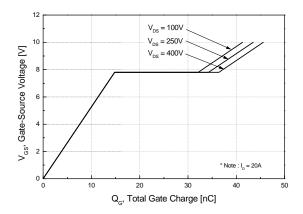


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

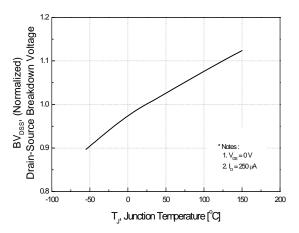


Figure 8. On-Resistance Variation vs. Temperature

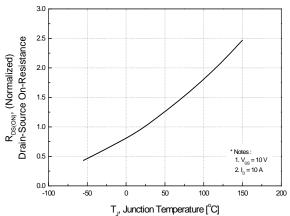
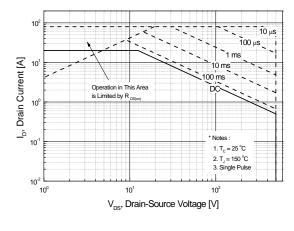


Figure 9-1. Maximum Safe Operating Area - FDP20N50

Figure 9-2. Maximum Safe Operating Area - FDPF20N50



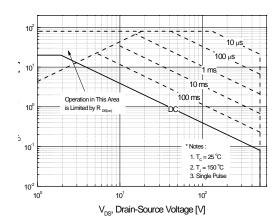
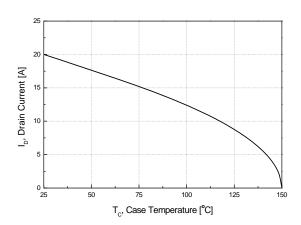


Figure 10. Maximum Drain Currentvs. Case Temperature



Typical Performance Characteristics (Continued)

Figure 11-1. Transient Thermal Response Curve - FDP20N50

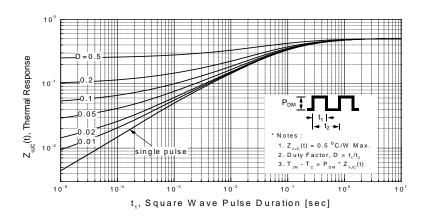
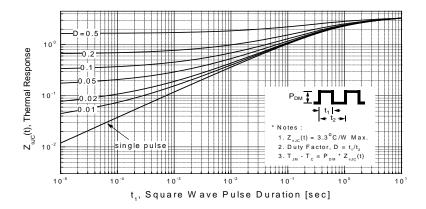
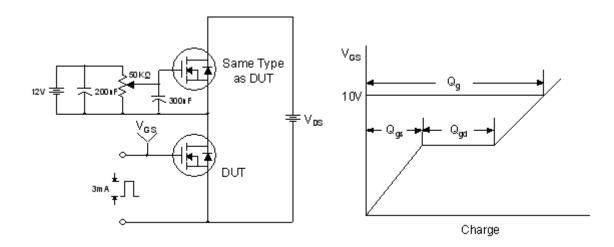


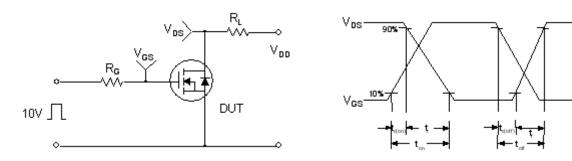
Figure 11-2. Transient Thermal Response Curve - FDPF20N50



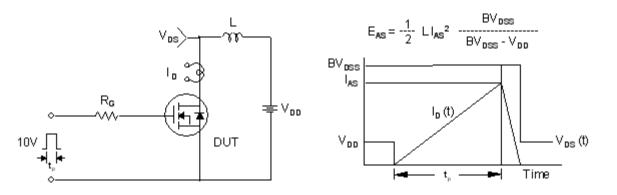
Gate Charge Test Circuit & Waveform



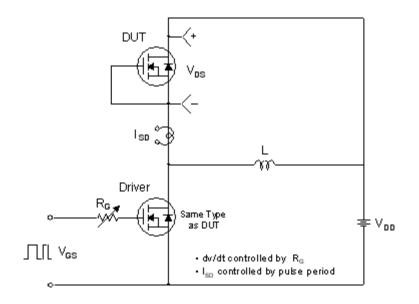
Resistive Switching Test Circuit & Waveforms

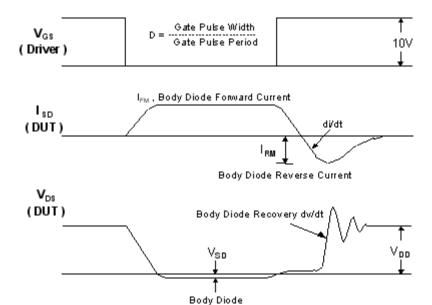


Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms

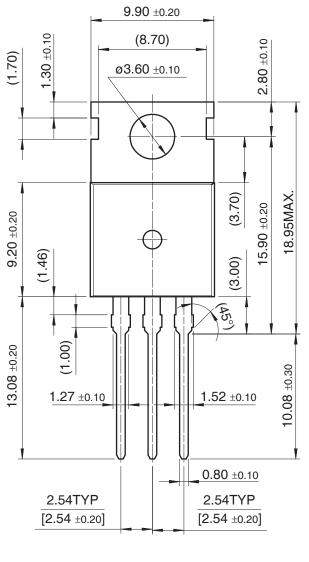


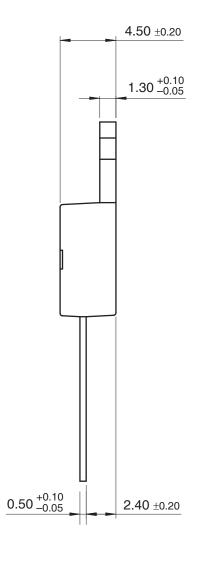


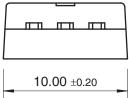
Forward Voltage Drop

Mechanical Dimensions

TO-220







查询"FDPF20N50T"供应商 **Mechanical Dimensions** TO-220F 2,54±0*2*0 Ø3.18±010 10.16±0.20 (0.70) (7.00) 3,3040.0 Potting \bigoplus <u>A' (Pottlng)</u> 함 (1.00×45ን MAX1.47 0.70±0.10 Эŋ. 0.5048 2.76±0.20 0.35±0.10 2.54TYP 254TYP [2.54±0.20] (2.54±0.20) 9,40±020



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